TOSHIBA Photocoupler IRED + Photo IC

TLP751F

Digital Logic Ground Isolation Line Receiver Microprocessor System Interfaces Switching Power Supply Feedback Control **Analog Signal Isolation**

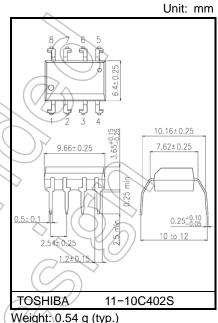
The TOSHIBA TLP751F consists of a high-output infrared emitting diode and a high speed detector of one chip photo diodetransistor. This unit is 8-lead DIP.

TLP751F has internal base connection. This base pin should be used for analog application or enable operation. If base pin is open, output signal will be noisy by environmental condition. For this case, TLP750F is suitable.

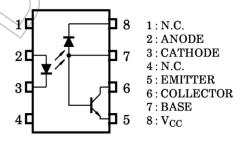
- Switching speed: $t_{pHL} = 0.2 \mu s$ (typ.) $t_{pLH} = 1.0 \mu s \text{ (typ.) (RL=1.9k}\Omega)$
- TTL compatible
- Isolation voltage: 5000Vrms (min)
- UL-recognized: UL 1577, File No.E67349
- cUL-recognized: CSA Component Acceptance Service No.5A File No.E67349
- VDE-approved: EN 60747-5-5 (Note 1)

Note 1: When a VDE approved type is needed, please designate the Option(D4).

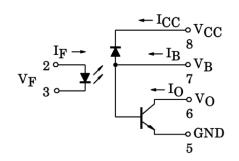
Creepage distance: 8.0mm (min) Clearance: 8.0mm (min) Insulation thickness: 0.4mm (min)



Pin Configuration (top view)



Schematic



Start of commercial production 1987-09

Absolute Maximum Ratings (Ta = 25°C)

	Characteristic		Symbol	Rating	Unit
LED	Forward current	(Note 1)	lF	25	mA
	Pulse forward current	(Note 2)	IFP	50	mA
	Peak transient forward current	(Note 3)	IFPT	1	Α
	Reverse voltage		VR	5	V
	Diode power dissipation	(Note 4)	PD	45	mW
	Output current		lo (8	mA
	Peak output current		IOP	16	mA
Detector	Output voltage		Yo	−0.5 to 15	V
	Supply voltage		Vcc	-0.5 to 15	V
۵	Base current	_	IB	5 (mA
	Output power dissipation	(Note 5)	Po	100	mW
	Emitter-base reverse voltage		VEB	5	V
Оре	Operating temperature range))T _{opr}	-55 to 100	Ç
Stor	rage temperature range		T _{stg}	-55 to 125	√,c
Lea	d solder temperature(10 s)	(Note 6)	T _{sol}	260	°C
Isola	ation voltage (AC, 60 s, R.H.≤ 60 %)	(Note 7)	BVs	5000	Vrms

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

- (Note 1) Derate 0.8 mA above 70 °C
- (Note 2) 50 % duty cycle, 1 ms pulse width.

 Derate 1.6 mA / °C above 70 °C
- (Note 3) Pulse width ≤ 1 µs, 300 pps.
- (Note 4) Derate 0.9 mW / °C above 70 °C
- (Note 5) Derate 2 mW / °C above 70 °C
- (Note 6) Soldering portion of lead: up to 2mm from the body of the device.
- (Note 7) Device considered a two terminal device: Pins 1, 2, 3 and 4 shorted together and pins 5, 6, 7 and 8 shorted together.

Electrical Characteristics (Ta = 25°C)

	Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
	Forward voltage	VF	I _F = 16 mA	_	1.65	1.85	V
CED	Forward voltage Temperature coefficient	ΔV _F / ΔTa	IF = 16 mA		-2	_	mV / °C
	Reverse current	I_R	V _R = 5 V	/	_	10	μΑ
	Capacitance between terminal	СТ	VF = 0 V, f = 1 MHz		45	_	pF
Detector	High level output current	IOH (1)	IF = 0 mA, VCC = VO = 5.5 V		3	500	nA
		IOH (2)	IF = 0 mA, V _{CC} = V _O = 15 V	\\\\	_	5	
		Іон	$I_F = 0 \text{ mA}, V_{CC} = V_O = 15 \text{ V}$ Ta = 70 °C	<u> </u>	-	50	μА
	High level supply voltage	Іссн	IF = 0 mA, VCC = 15 V	_	0.01	1	μΑ
	Current transfer ratio	Io / IF	IF = 16 mA, V _{CC} = 4.5 V V _O = 0.4 V	10	30	<u>></u>	%
Coupled/ Insulation	Low level output voltage	Vol	IF = 16 mA, VCC = 4.5 V IO = 1.1 mA	(0.4	V
	Resistance (input-output)	Rs	R.H. ≤ 60 %, V _S = 500 V _{DC} (Note7)	1×10 ¹²	1014	_	Ω
	Capacitance (input-output)	Cs	Vs = 0 V, f = 1 MHz (Note7)		0.8	_	pF
	Isolation voltage	BVs	AC, 60 s (Note7)	5000	_	_	Vrms

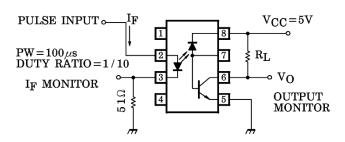
Switching Characteristics (Ta = 25°C, Vcc = 5V)

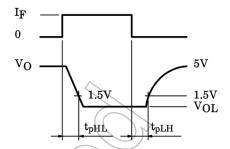
Characteristic	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Propagation delay time (H→L)	tрнL		I_F = 16 mA, R_L = 4.1 kΩ	_	0.2	_	μS
Propagation delay time (L→H)	(t _{pLH})		IF = 16 mA, R_L = 4.1 $k\Omega$	ı	1.0		μS
Common mode transient immunity at logic high output (Note 8)	СМН	2	$I_F = 0$ mA, $V_{CM} = 200 V_{p-p}$ R _L = 4.1 k Ω	_	400	_	V / μs
Common mode transient immunity at logic low output (Note 8)	CML		I_F =16 mA V_{CM} = 200 V_{p-p} R_L = 4.1 $k\Omega$	_	-1000	_	V / μs

(Note 8) CM_L is the maximum rate of fall of the common mode voltage that can be sustained with the output voltage in the logic low state (Vo < 0.8 V).

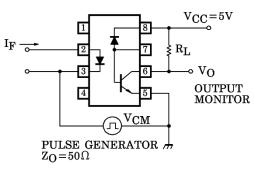
 CM_H is the maximum rate of rise of the common mode voltage that can be sustained with the output voltage in the logic high state ($V_O > 2.0 \text{ V}$).

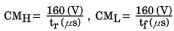
Test Circuit 1: Switching Time Test Circuit

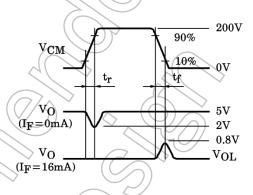


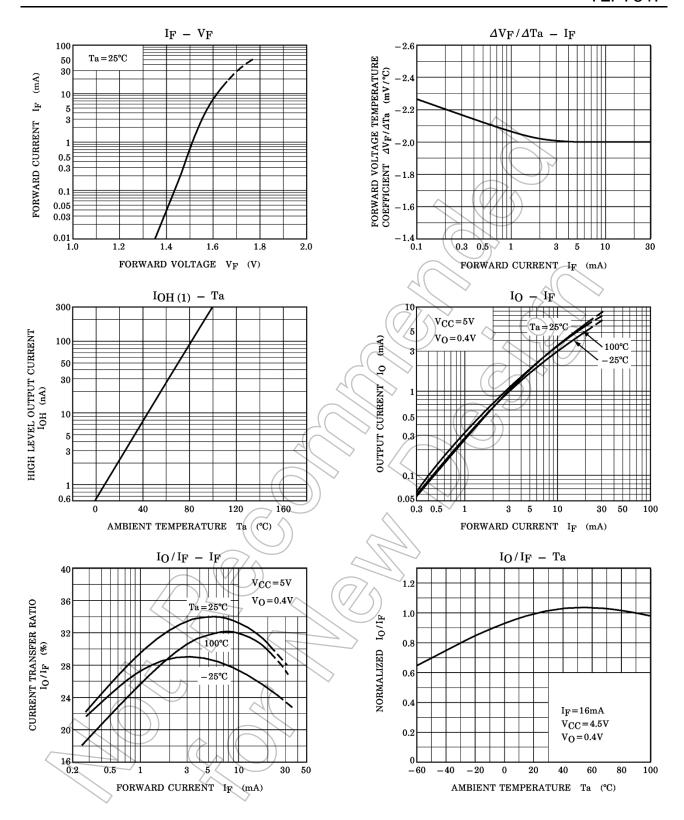


Test Circuit 2: Common Mode Noise Immunity Test Circuit









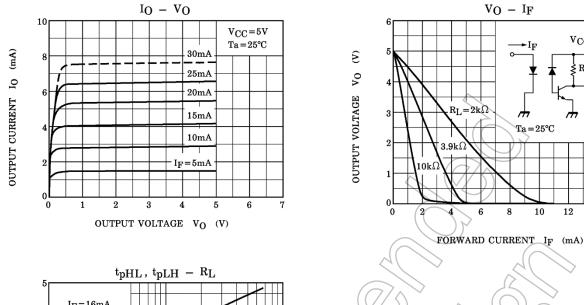
NOTE: The above characteristics curves are presented for reference only and not guaranteed by production test, unless otherwise noted.

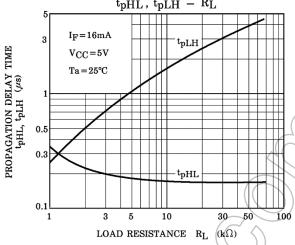
 $V_{\rm CC} = 5V$

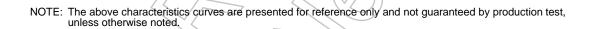
 $R_{\rm L}$

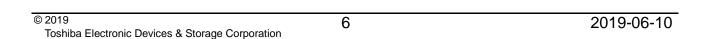
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Ta=25°C









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